Approved by:

Checked by:

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# **SPECIFICATION**

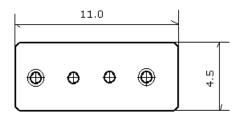
MODEL: HD F903AF11



WUXI HAODA ELECTRONICS COMPANY LIMITED

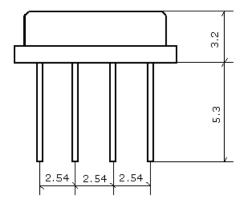
# 1. Package Dimension

(F-11)



NO	Function
1	Input
2	Ground
3	Ground
4	Output

Unit:mm



# 2. Marking

## **HD F903A**

1.Color: Black or Blue

2.903.75: Center Frequency(MHz)

3.Performance

3.1 Application

Low-Loss SAW Filter of cordless system.

Center Frequency:903 MHz

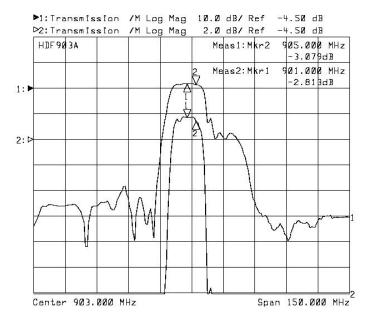
3.2 Maximum Rating

Operation Temperature Range	-20°C to +50°C
Operation reinperature Range	-20 C 10 +30 C
G. The state of th	
Storage Temperature Range	-40°C to +85°C
DC. Permissive Voltage	10 V DC. max.
2 of 1 change to the stange	10 / 20/11411
Maximum Immy Dayson	OdD
Maximum Input Power	0dBm

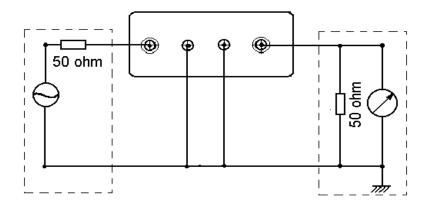
#### 3.3 Electronic Characteristics

Item	Specification
Center Frequency(fo)	903.75 MHz
Insertion Loss	4.0dBmax
	902.75~904.75 MHz
Pass Band Ripple	1.5dBmax
	902.75~904.75 MHz
Ripple Deviation	
858~662 MHz	45dBmin
880~883 MHz	35dBmin
923~926 MHz	22dBmin
926~928 MHz	22dBmin
944~948 MHz	40dBmin
Terminating Impedance	50 Ω
Operating Temperature Range	-10°C to +70°C

#### 3.4 Frequency Characteristics



#### 3.5 Test Circuit



## 4. ENVIRONMENTAL CHARACTERISTICS

#### 4-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in table 1.

#### 4-2 Low temperature exposure

Subject the device to  $-20^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in table 1.

#### 4-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}\text{C}$  for 30 minutes. Following by a high temperature of  $+80^{\circ}\text{C}$  for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in table 1.

#### 4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in table 1.

#### 4-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in table 1.

#### 4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in table 1.

#### 4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in table 1.

#### 4-8 Lead fatigue

#### 4-8-1 Pulling test

Weight along with the direction of lead without an shock 1kg. The device shall satisfy all the initial Characteristics.

#### 4-8-2 Bending test

Lead shall be subject to withstand against 90°C bending with 450g weight in the direction of thickness. This operation shall be done toward both direction. The device shall show no evidence of damage and shall satisfy all the initial electrical characteristics.

#### 5. REMARK

#### 5.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

#### 5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

### 5.3 Soldering

Only leads of component may be soldered . Please avoid soldering another part of component.